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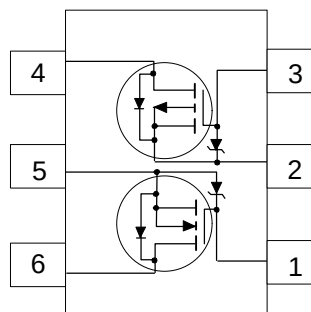
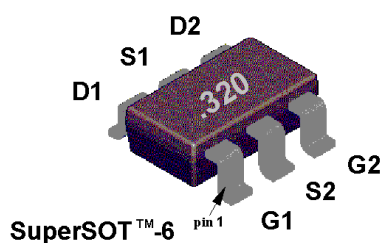
Dual N & P Channel , Digital FET

General Description

These dual N & P Channel logic level enhancement mode field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. The device is an improved design especially for low voltage applications as a replacement for bipolar digital transistors in load switching applications. Since bias resistors are not required, this dual digital FET can replace several digital transistors with difference bias resistors.

Features

- N-Ch 25 V, 0.22 A, $R_{DS(ON)} = 5 \Omega @ V_{GS} = 2.7 \text{ V}$.
- P-Ch 25 V, -0.12 A, $R_{DS(ON)} = 13 \Omega @ V_{GS} = -2.7 \text{ V}$.
- Very low level gate drive requirements allowing direct operation in 3 V circuits. $V_{GS(th)} < 1.5 \text{ V}$.
- Gate-Source Zener for ESD ruggedness. >6kV Human Body Model
- Replace NPN & PNP digital transistors.



Absolute Maximum Ratings $T_A = 25^\circ\text{C}$ unless other wise noted

Symbol	Parameter	N-Channel	P-Channel	Units
V _{DSS} , V _{CC}	Drain-Source Voltage, Power Supply Voltage	25	-25	V
V _{GSS} , V _{IN}	Gate-Source Voltage,	8	-8	V
I _D , I _O	Drain/Output Current - Continuous	0.22	-0.12	A
	- Pulsed	0.5	-0.5	
P _D	Maximum Power Dissipation (Note 1a)	0.9		W
	(Note 1b)	0.7		
T _J , T _{STG}	Operating and Storage Tempature Ranger	-55 to 150		°C
ESD	Electrostatic Discharge Rating MIL-STD-883D Human Body Model (100pf / 1500 Ohm)	6		kV

THERMAL CHARACTERISTICS

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	140	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	60	$^\circ\text{C/W}$

DMOS Electrical Characteristics ($T_A = 25\text{ }^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Type	Min	Typ	Max	Units
OFF CHARACTERISTICS							
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	N-Ch	25			V
		V _{GS} = 0 V, I _D = -250 μA	P-Ch	-25			
ΔBV _{DSS} /ΔT _J	Breakdown Voltage Temp. Coefficient	I _D = 250 μA, Referenced to 25 °C	N-Ch		25		mV / °C
		I _D = -250 μA, Referenced to 25 °C	P-Ch		-20		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 20 V, V _{GS} = 0 V, T_J = 55°C	N-Ch			1	μA
						10	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-20 V, V _{GS} = 0 V, T_J = 55°C	P-Ch			-1	μA
						-10	
I _{GSS}	Gate - Body Leakage Current	V _{GS} = 8 V, V _{DS} = 0 V	N-Ch			100	nA
		V _{GS} = -8 V, V _{DS} = 0 V	P-Ch			-100	nA
ON CHARACTERISTICS (Note 2)							
ΔV _{GS(th)} /ΔT _J	Gate Threshold Voltage Temp. Coefficient	I _D = 250 μA, Referenced to 25 °C	N-Ch		-2.1		mV / °C
		I _D = -250 μA, Referenced to 25 °C	P-Ch		1.9		
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	N-Ch	0.65	0.85	1.5	V
		V _{DS} = V _{GS} , I _D = -250 μA	P-Ch	-0.65	-1	-1.5	
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 2.7 V, I _D = 0.2 A T_J =125°C	N-Ch		3.8	5	Ω
					6.3	9	
		V _{GS} = 4.5 V, I _D = 0.4 A			3.1	4	
		V _{GS} = -2.7 V, I _D = -0.05 A T_J =125°C	P-Ch		10.6	13	
					15	21	
		V _{GS} = -4.5 V, I _D = -0.2 A			7.9	10	
I _{D(on)}	On-State Drain Current	V _{GS} = 2.7 V, V _{DS} = 5 V	N-Ch	0.2			A
		V _{GS} = -2.7 V, V _{DS} = -5 V	P-Ch	-0.05			
g _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 0.4 A	N-Ch		0.2		S
		V _{DS} = -5 V, I _D = -0.2 A	P-Ch		0.135		
DYNAMIC CHARACTERISTICS							
C _{iss}	Input Capacitance	N-Channel V _{DS} = 10 V, V _{GS} = 0 V, f = 1.0 MHz	N-Ch		9.5		pF
			P-Ch		11		
C _{oss}	Output Capacitance	P-Channel V _{DS} = -10 V, V _{GS} = 0 V, f = 1.0 MHz	N-Ch		6		pF
			P-Ch		7		
C _{rss}	Reverse Transfer Capacitance		N-Ch		1.3		pF
			P-Ch		1.4		

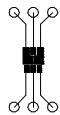
DMOS Electrical Characteristics (T_A = 25 °C unless otherwise noted)

Symbol	Parameter	Conditions	Type	Min	Typ	Max	Units
SWITCHING CHARACTERISTICS (Note 2)							
t _{D(on)}	Turn - On Delay Time	N-Channel V _{DD} = 6 V, I _D = 0.5 A, V _{GS} = 4.5 V, R _{GEN} = 50 Ω	N-Ch		5	11	nS
			P-Ch		6	12	
t _r	Turn - On Rise Time		N-Ch		4.5	10	nS
			P-Ch		6	12	
t _{D(off)}	Turn - Off Delay Time	P-Channel V _{DD} = -6 V, I _D = -0.5 A, V _{GEN} = -4.5 V, R _{GEN} = 50 Ω	N-Ch		4	10	nS
			P-Ch		7.4	15	
t _f	Turn - Off Fall Time		N-Ch		3.2	8	nS
			P-Ch		4	10	
Q _g	Total Gate Charge	N-Channel V _{DS} = 5 V, I _D = 0.2 A, V _{GS} = 4.5 V	N-Ch		0.29	0.4	nC
			P-Ch		0.23	0.32	
Q _{gs}	Gate-Source Charge	P-Channel V _{DS} = -5 V, I _D = -0.2A, V _{GS} = -4.5 V	N-Ch		0.105		nC
			P-Ch		0.12		
Q _{gd}	Gate-Drain Charge		N-Ch		0.045		nC
			P-Ch		0.03		
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS							
I _S	Maximum Continuous Drain-Source Diode Forward Current		N-Ch			0.5	A
			P-Ch			-0.5	
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 0.5 A (Note 2)	N-Ch		0.97	1.3	V
		V _{GS} = 0 V, I _S = -0.5 A (Note 2)	P-Ch		-1	-1.3	

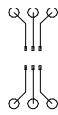
Notes:

- R_{θJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{θJC} is guaranteed by design while R_{θCA} is determined by the user's board design.

Typical R_{θJA} using the board layouts shown below on FR-4 PCB in a still air environment:



a. 140°C/W on a 0.125 in² pad of 2oz copper.



b. 180°C/W on a 0.005 in² pad of 2oz copper.

Scale 1 : 1 on letter size paper

- Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2.0%.

Typical Electrical Characteristics: N-Channel

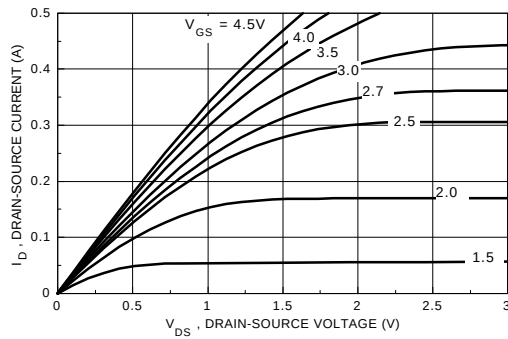


Figure 1. On-Region Characteristics.

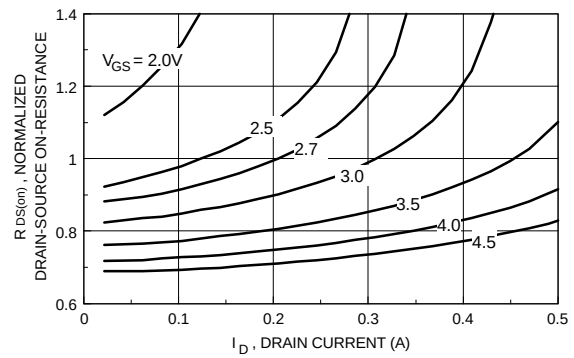


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

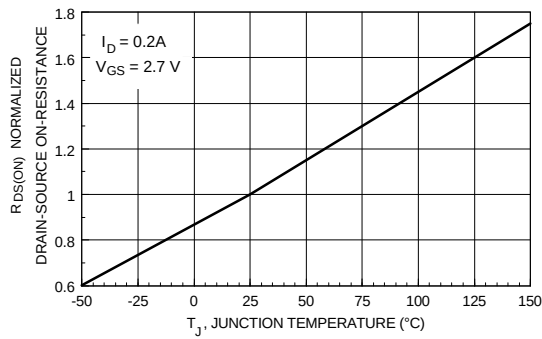


Figure 3. On-Resistance Variation with Temperature.

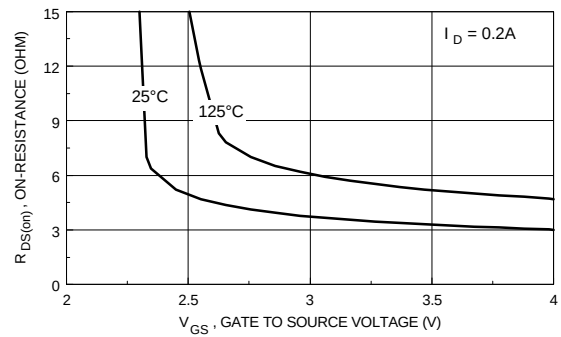


Figure 4. On Resistance Variation with Gate-To- Source Voltage.

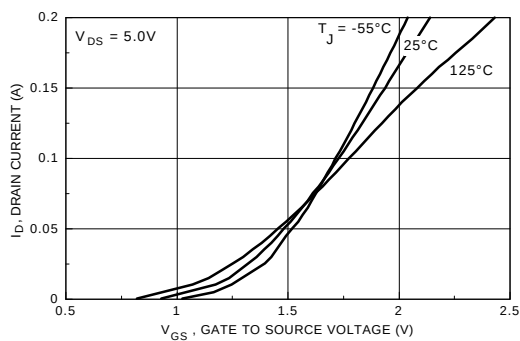


Figure 5. Transfer Characteristics.

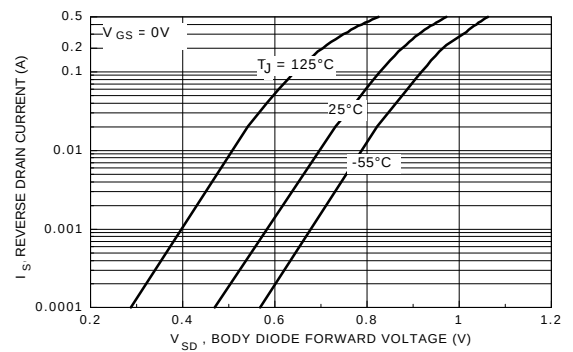


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Electrical Characteristics: N-Channel (continued)

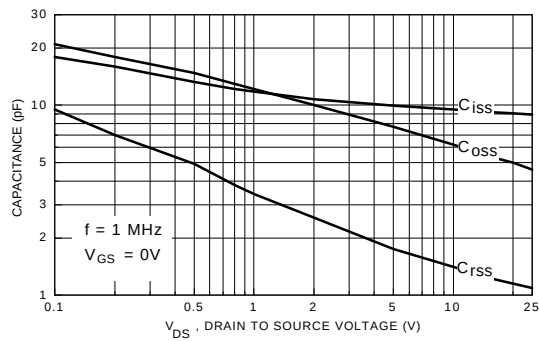


Figure 7. Capacitance Characteristics.

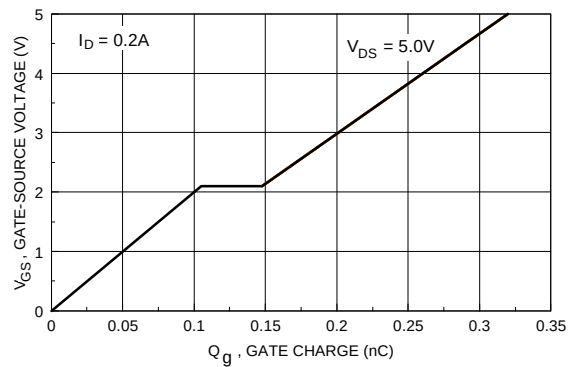


Figure 8. Gate Charge Characteristics.

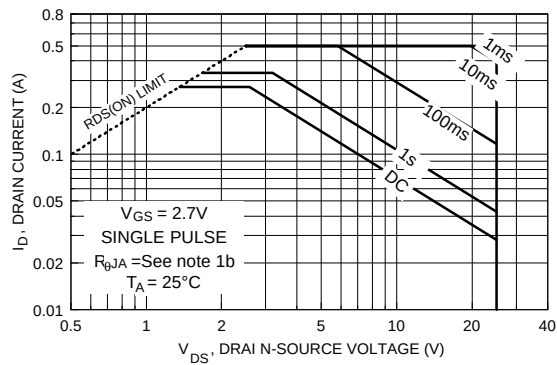


Figure 9. Maximum Safe Operating Area.

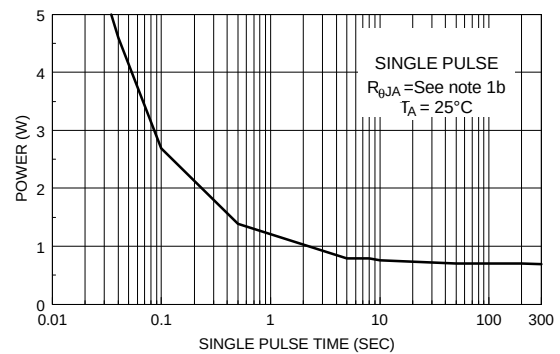


Figure 10. Single Pulse Maximum Power Dissipation.

Typical Electrical Characteristics: P-Channel

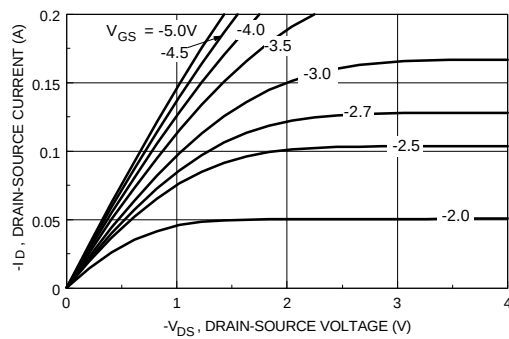


Figure 11. On-Region Characteristics.

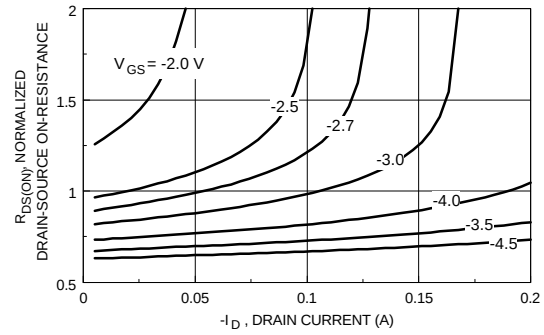


Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.

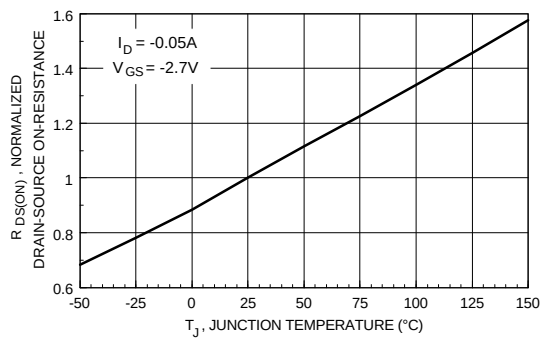


Figure 13. On-Resistance Variation with Temperature.

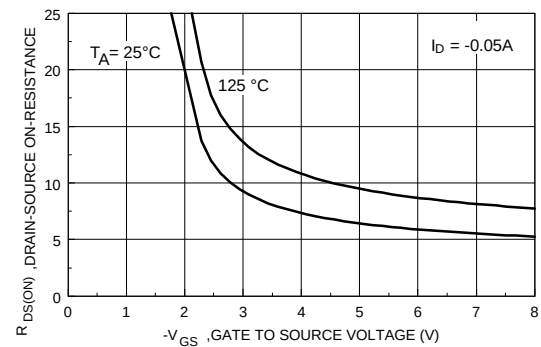


Figure 14. On Resistance Variation with Gate-To- Source Voltage.

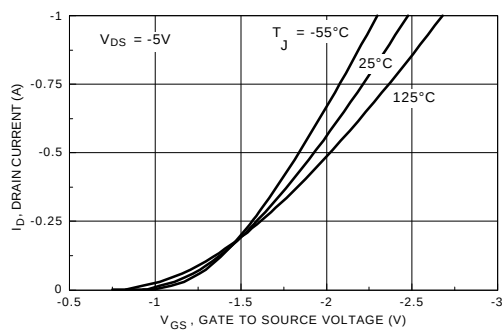


Figure 15. Transfer Characteristics.

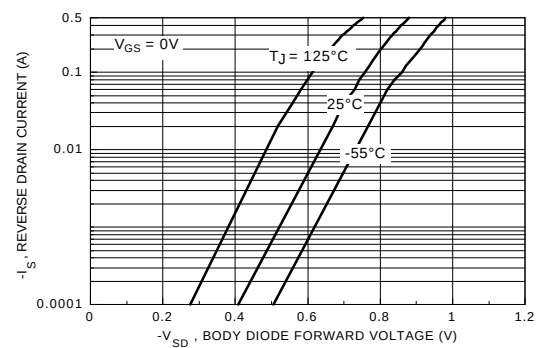


Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Electrical Characteristics: P-Channel (continued)

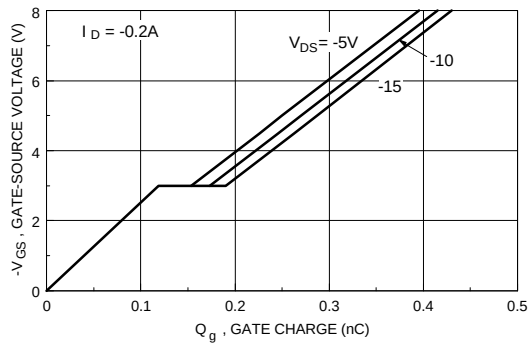


Figure 17. Gate Charge Characteristics.

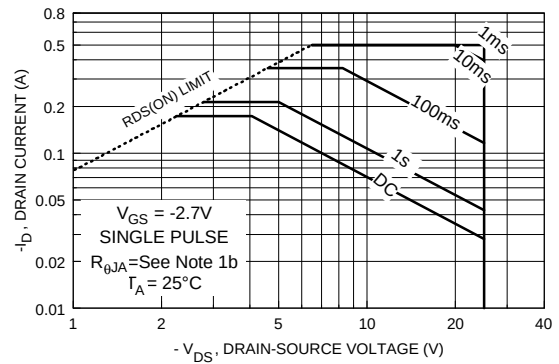


Figure 18. Maximum Safe Operating Area.

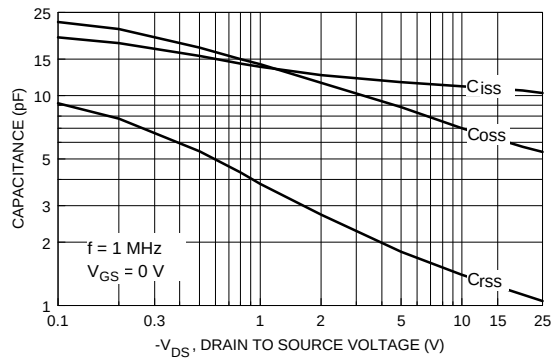


Figure 19. Capacitance Characteristics.

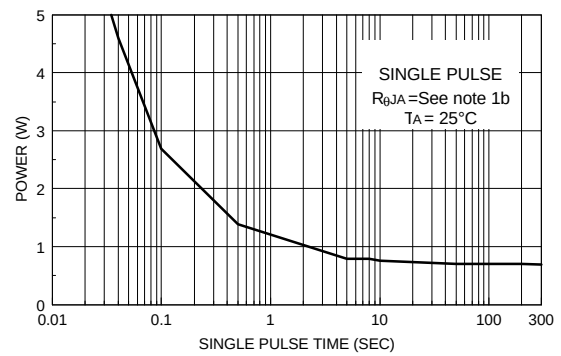


Figure 20. Single Pulse Maximum Power Dissipation.

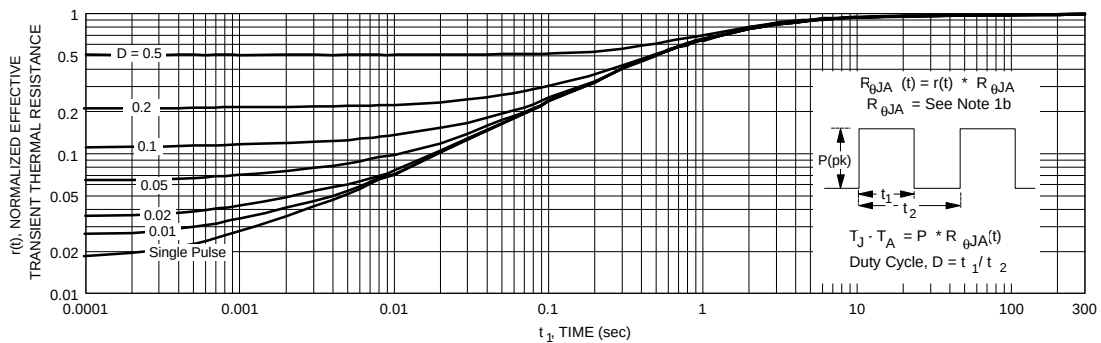


Figure 21. Transient Thermal Response Curve.

Note: Thermal characterization performed using the conditions described in note 1b. Transient thermal response will change depending on the circuit board design.

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